

**Search Notes**

Application/Control No.

10/662,164

Examiner

Maikhanh Nguyen

Applicant(s)/Patent under  
Reexamination

CHENG ET AL.

Art Unit

2176

**SEARCHED**

| Class   | Subclass | Date      | Examiner |
|---------|----------|-----------|----------|
| 715     | 530      | 5/1/2006  | MK       |
| 713     | 161,165  | 5/1/2006  | MK       |
| 713     | 166,170  | 5/1/2006  | MK       |
| 713     | 176      | 5/1/2006  | MK       |
| 707     | 10       | 5/1/2006  | MK       |
| Updated | Search   | 2/16/2007 | MK       |
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**INTERFERENCE SEARCHED**

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**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

|   | DATE      | EXMR |
|---|-----------|------|
| Inventor Name Search  | 5/1/2006  | MK   |
| West Search (USPAT, US-PGPUB,<br>EPO, JPO, DERWENT) See Search<br>History Printout  | 5/1/2006  | MK   |
| West Updated (USPAT, US-PGPUB,<br>EPO, JPO, DERWENT) See Search<br>History Printout | 2/16/2007 | MK   |
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